

FCC TEST REPORT

For

GUANGDONG PISEN ELECTRONICS CO., LTD.

Portable Wireless Bluetooth Speaker

Model No.: SPK-B003

Prepared For : GUANGDONG PISEN ELECTRONICS CO., LTD.

Address 9 QINFU 1ST.STREET JINTANG INDUSTRY ZONE, LIUYUE,

· LONGGANG, SHENZHEN, CHINA

Prepared By : Shenzhen Anbotek Compliance Laboratory Limited

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Report Number : R0217040065W2

Date of Test : Apr. 25~May 26, 2017

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TEST REPORT

Applicant : GUANGDONG PISEN ELECTRONICS CO., LTD.

Manufacturer : GUANGDONG PISEN ELECTRONICS CO., LTD.

Product Name : Portable Wireless Bluetooth Speaker

Model No. : SPK-B003

Trade Mark : PISEN

Rating(s) : Input DC 5V, 2A (Battery: DC 3.7V, 2500mAh)

Test Standard(s) : FCC Part15 Subpart C 2016, Section 15.247

Test Method(s) : ANSI C63.10: 2013, KDB558074 D01 DTS Meas Guidance v04

The device described above is tested by Shenzhen Anbotek Compliance Laboratory Limited to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The measurement results are contained in this test report and Shenzhen Anbotek Compliance Laboratory Limited is assumed full of responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT (Equipment Under Test) is technically compliant with the FCC Part 15 Subpart C requirements.

This report applies to above tested sample only and shall not be reproduced in part without written approval of Shenzhen Anbotek Compliance Laboratory Limited.

Date of Test:	Apr. 25~May 26, 2017
Prepared by:	Winkey Wang
	(Tested Engineer / Winkey Wang)
Reviewer:	Amy Ding
	(Project Manager / Amy Ding)
: Approved & Authorized Signer:	Ton Jalen
	(Manager / Tom Chen)



1. General Information

1.1. Client Information

Applicant	:	GUANGDONG PISEN ELECTRONICS CO., LTD.
Address	:	9 QINFU 1ST.STREET JINTANG INDUSTRY ZONE, LIUYUE, LONGGANG, SHENZHEN, CHINA
Manufacturer	:	GUANGDONG PISEN ELECTRONICS CO., LTD.
Address	:	9 QINFU 1ST.STREET JINTANG INDUSTRY ZONE, LIUYUE, LONGGANG, SHENZHEN, CHINA

1.2. Description of Device (EUT)

Product Name	:	Portable Wireless Bluetooth Speaker				
Model No.	:	SPK-B003	SPK-B003			
Trade Mark	:	PISEN				
Test Power Supply	:	AC 120V, 60Hz for adapter/AC 240V, 60Hz for adapter/ DC 3.7V By Battery				
Product :		Operation Frequency:	BT 4.0+EDR: 2402-2480MHz			
		Number of Channel:	BT 4.0: 40 Channels BT EDR: 79 Channels			
	Modulation Type:		BT 4.0: GFSK BT EDR: GFSK, π/4DQPSK, 8DPSK			
		Antenna Type:	PCB Antenna			
		Antenna Gain(Peak):	0.5 dBi			

Remark: 1) For a more detailed features description, please refer to the manufacturer's specifications or the User's Manual.

2)This report is for BT 4.0

1.3. Auxiliary Equipment Used During Test

Adapter	:	Manufacturer: ZTE	
		M/N: STC-A2050I1000USBA-C	
		S/N: 201202102100876	
		nput: 100-240V~50/60Hz 0.3A	
		Output: DC 5V, 1000mA	



1.4. Description of Test Modes

To investigate the maximum EMI emission characteristics generates from EUT, the test system was pre-scanning tested base on the consideration of following EUT operation mode or test configuration mode which possible have effect on EMI emission level. Each of these EUT operation mode(s) or test configuration mode(s) mentioned above was evaluated respectively.

Pretest Mode	Description
Mode 1	CH00
Mode 2	CH19
Mode 3	СН39
Mode 4	Keeping TX mode

For Conducted Emission			
Final Test Mode	Description		
Mode 4	Keeping TX mode		

For Radiated Emission					
Final Test Mode	Description				
Mode 1	CH00				
Mode 2	CH19				
Mode 3	CH39				

Note:

- (1) The measurements are performed at the highest, middle, lowest available channels.
- (2) The data rate was set in 1Mbps for radiated emission due to the highest RF output power.

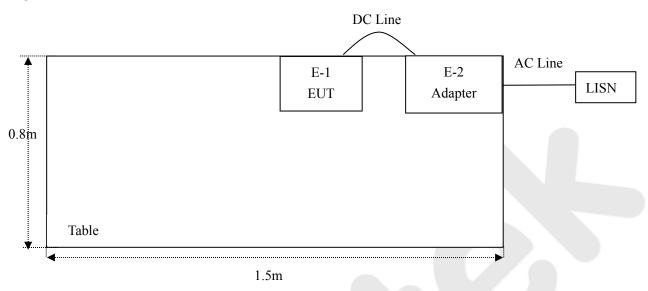
1.5. List of channels

Channel	Freq.								
	(MHz)								
00	2402	09	2420	18	2438	27	2456	36	2474
01	2404	10	2422	19	2440	28	2458	37	2476
02	2406	11	2424	20	2442	29	2460	38	2478
03	2408	12	2426	21	2444	30	2462	39	2480
04	2410	13	2428	22	2446	31	2464		
05	2412	14	2430	23	2448	32	2466		
06	2414	15	2432	24	2450	33	2468		
07	2416	16	2434	25	2452	34	2470		
08	2418	17	2436	26	2454	35	2472		

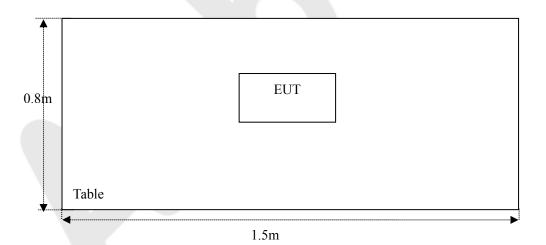


1.6. Description Of Test Setup

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1.7. Test Equipment List

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	Two-Line V-network	Rohde & Schwarz	ENV216	100055	Jul. 19, 2016	1 Year
2.	EMI Test Receiver	Rohde & Schwarz	ESCI	100627	Jun. 17, 2016	1 Year
3.	RF Switching Unit	Compliance Direction	RSU-M2	38303	Jun. 17, 2016	1 Year
4.	Spectrum Analysis	Agilent	E4407B	US39390582	Jul. 12, 2016	1 Year
5	Preamplifier	Instruments corporation	EMC011830	980100	Jun. 17, 2016	1 Year
6.	EMI Test Receiver	Rohde & Schwarz	ESPI	101604	Jun. 17, 2016	1 Year
7.	Double Ridged Horn Antenna	Instruments corporation	GTH-0118	351600	May 06, 2017	1 Year
8.	Bilog Broadband Antenna	Schwarzbeck	VULB9163	VULB 9163-289	May 06, 2017	1 Year
9.	Loop Antenna	Schwarzbeck	FMZB1519	012	May 11, 2017	1 Year
10.	Pre-amplifier	SONOMA	310N	186860	Jun. 17, 2016	1 Year
11	EMI Test Software EZ-EMC	SHURPLE	N/A	N/A	N/A	N/A
12.	Power Sensor	Agilent	KFSW150502	15I00041SN045	Jun. 17, 2016	1 Year
13.	MXA Spectrum Analysis	Agilent	N9020A	MY51170037	Jun. 17, 2016	1 Year
14.	MXG RF Vector Signal Generator	Agilent	N5182A	MY48180656	Jun. 17, 2016	1 Year
15	Signal Generator	Agilent	E4421B	MY41000743	Jun. 17, 2016	1 Year
16.	DC Power supply	IV	IV-8080	YQSB0096	Jun. 17, 2016	1 Year
17.	TEMP&HUMI PROGRAMMABLE CHAMBER	Bell Group	BE-THK-150 M8	SE-0137	Jun. 17, 2016	1 Year

1.8. Measurement Uncertainty

Radiation Uncertainty	:	Ur = 4.1 dB (Horizontal)
		Ur = 4.3 dB (Vertical)
Conduction Uncertainty	:	Uc = 3.4dB



1.9. Description of Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC-Registration No.: 752021

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registed and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration 752021, July 06, 2016.

IC-Registration No.: 8058A-1

Shenzhen Anbotek Compliance Laboratory Limited., EMC Laboratory has been registered and fully described in a report filed with the (IC) Industry Canada. The acceptance letter from the IC is maintained in our files. Registration 8058A, June 13, 2016.

Test Location

All Emissions tests were performed at

Shenzhen Anbotek Compliance Laboratory Limited. at 1/F., Building 1, SEC Industrial Park, No.0409 Qianhai Road, Nanshan District, Shenzhen, Guangdong, China



2. Summary of Test Results

Standard Section	Test Item	Result			
15.203/15.247(c)	Antenna Requirement	PASS			
15.207	Conducted Emission	PASS			
15.205/15.209	Spurious Emission	PASS			
15.247(b)(3)	Conducted Peak Output Power	PASS			
15.247(a)(2)	6dB Occupied Bandwidth	PASS			
15.247(e)	Power Spectral Density	PASS			
15.247(d)	Band Edge	PASS			
Remark: "N/A" is an abbreviation for Not Applicable.					



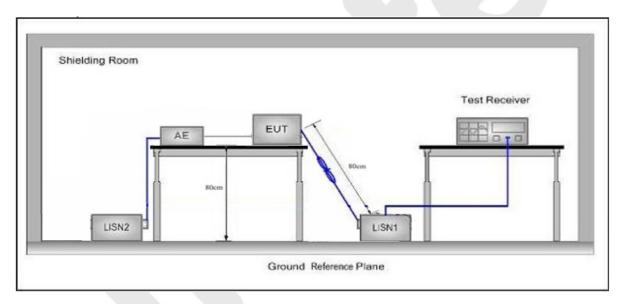
3. Conducted Emission Test

3.1. Test Standard and Limit

Test Standard	FCC Part15 Section 15.207					
	Eraguanav	Maximum RF L	ine Voltage (dBuV)			
	Frequency	Quasi-peak Level	Average Level			
Test Limit	150kHz~500kHz	66 ~ 56 *	56 ~ 46 *			
	500kHz~5MHz	56	46			
	5MHz~30MHz	60	50			

Remark: (1) *Decreasing linearly with logarithm of the frequency.

3.2. Test Setup



3.3. Test Procedure

The EUT system is connected to the power mains through a line impedance stabilization network (L.I.S.N.). This provides a 50ohm coupling impedance for the EUT system. Please refer the block diagram of the test setup and photographs. Both sides of AC line are checked to find out the maximum conducted emission. In order to find the maximum emission levels, the relative positions of equipment and all of the interface cables shall be changed according to FCC ANSI C63.10-2013 on Conducted Emission Measurement.

The bandwidth of test receiver (ESCI) set at 9kHz.

The frequency range from 150kHz to 30MHz is checked.

3.4. Test Data

Please to see the following pages

⁽²⁾ The lower limit shall apply at the transition frequency.

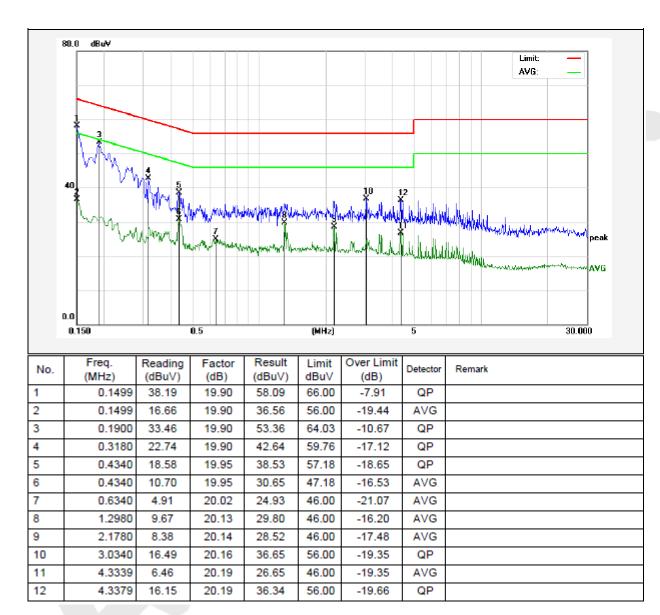


Test Site: 1# Shielded Room Operating Condition: Keeping TX mode

Test Specification: AC 120V, 60Hz for adapter

Comment: Live Line

Tem.:25℃ Hum.:50%



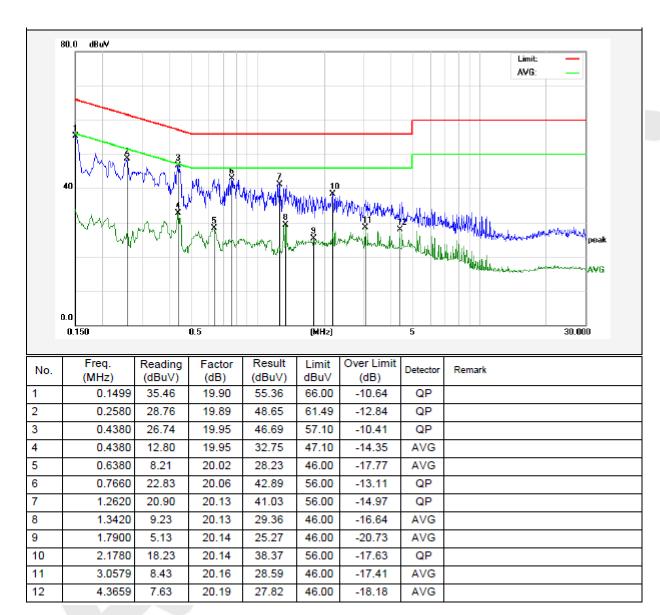


Test Site: 1# Shielded Room Operating Condition: Keeping TX mode

Test Specification: AC 120V, 60Hz for adapter

Comment: Neutral Line

Tem.:25°C Hum.:50%



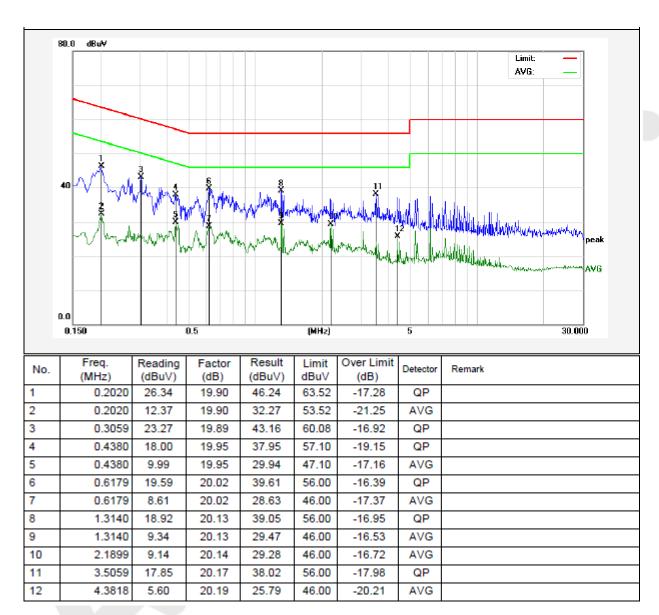


Test Site: 1# Shielded Room Operating Condition: Keeping TX mode

Test Specification: AC 240V, 60Hz for adapter

Comment: Live Line

Tem.:25℃ Hum.:50%



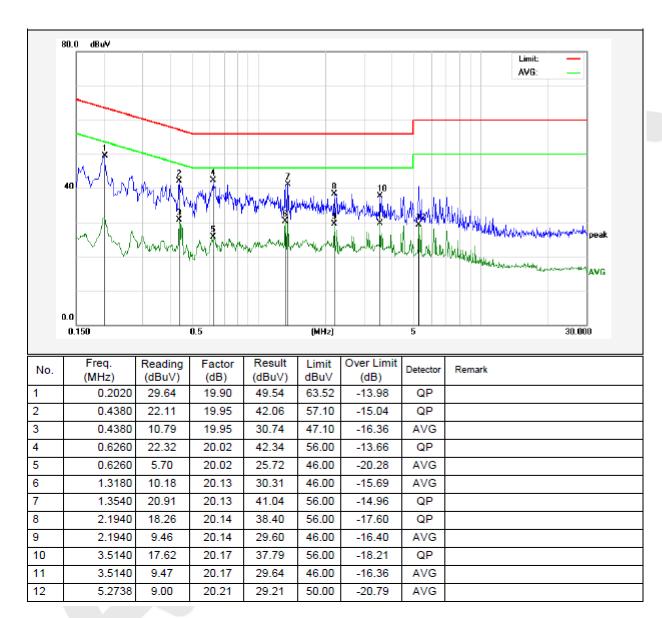


Test Site: 1# Shielded Room Operating Condition: Keeping TX mode

Test Specification: AC 240V, 60Hz for adapter

Comment: Neutral Line

Tem.:25°C Hum.:50%





4. Radiation Spurious Emission and Band Edge

4.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.209 and 15.205								
	Frequency (MHz)	Field strength (microvolt/meter)	Limit (dBuV/m)	Remark	Measurement distance (m)				
	0.009MHz~0.490MHz	2400/F(kHz)	-	<u>-</u>	300				
	0.490MHz-1.705MHz	24000/F(kHz)	-	-	30				
	1.705MHz-30MHz	30	-	1	30				
Test Limit	30MHz~88MHz	100	40.0	Quasi-peak	3				
	88MHz~216MHz	150	43.5	Quasi-peak	3				
	216MHz~960MHz	200	46.0	Quasi-peak	3				
	960MHz~1000MHz	500	500 54.0 Quasi-peak		3				
	Above 1000MHz	500	54.0	Average	3				
	AUUVE 1000IVII1Z	-	74.0	Peak	3				

Remark:

- (1) The lower limit shall apply at the transition frequency.
- (2) 15.35(b), Unless otherwise specified, the limit on peak radio frequency emissions is 20dB above the maximum permitted average emission limit applicable to the equipment under test. This peak limit applies to the total peak emission level radiated by the device.

4.2. Test Setup

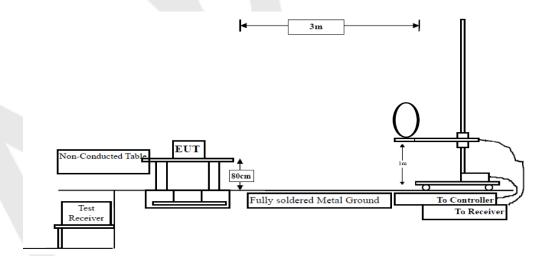


Figure 1. Below 30MHz

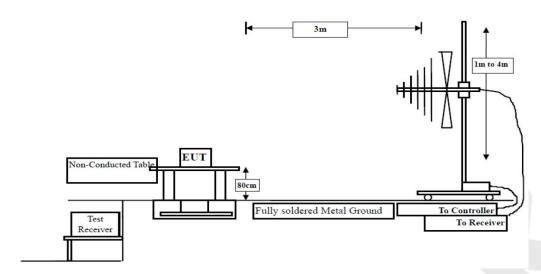


Figure 2. 30MHz to 1GHz

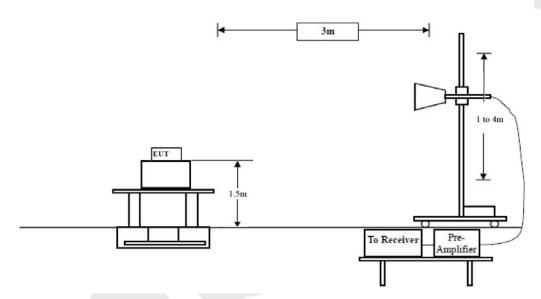


Figure 3. Above 1 GHz

4.3. Test Procedure

For below 1GHz: The EUT is placed on a turntable, which is 0.8m above the ground plane.

For above 1GHz: The EUT is placed on a turntable, which is 1.5m above the ground plane.

The turn table can rotate 360 degrees to determine the position of the maximum emission level. The EUT is set 3 meters away from the receiving antenna which is mounted on a antenna tower. The antenna can be moved up and down from 1 to 4 meters to find out the maximum emission level. Rotated the EUT through three orthogonal axes to determine the maximum emissions, both horizontal and vertical polarization of the antenna are set on test. The EUT is tested in 9*6*6 Chamber. The device is evaluated in xyz orientation.

For 9kHz to 150kHz, Set the spectrum analyzer as:

RBW = 200Hz, VBW = 1kHz, Detector= Quasi-Peak, Trace mode= Max hold, Sweep- auto couple.

For 150kHz to 30MHz, Set the spectrum analyzer as:

RBW = 9KHz, VBW = 30kHz, Detector= Quasi-Peak, Trace mode= Max hold, Sweep- auto couple.



For 30MHz to 1000MHz, Set the spectrum analyzer as:

RBW = 100kHz, VBW = 300kHz, Detector= Quasi-Peak, Trace mode= Max hold, Sweep- auto couple.

.

For above 1GHz,Set the spectrum analyzer as:

RBW =1MHz, VBW =1MHz, Detector= Peak, Trace mode= Max hold, Sweep- auto couple.

RBW =1MHz, VBW =10Hz, Detector= Average, Trace mode= Max hold, Sweep- auto couple.

4.4. Test Data

PASS

During the test, Pre-scan all kind of the place mode (X-axis, Y-axis, Z-axis), and found the X-axis is the worst case.

The test results of 9kHz-30MHz and above 18000MHz are attenuated more than 20dB below the permissible limits, so the results don't record in the report.

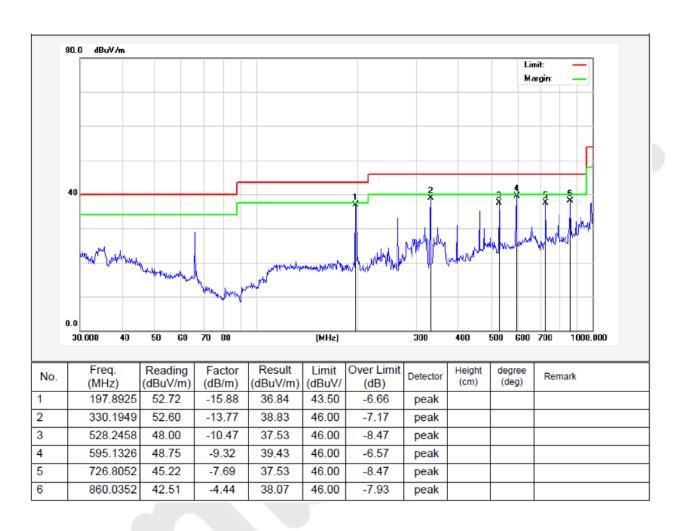


Test Results (30~1000MHz)

Job No.: 0217040065W Temp.(°C)/Hum.(%RH): 24.3 °C/55%RH

Standard: FCC PART 15C Power Source: DC 3.7V Battery inside

Test Mode: TX Mode Polarization: Horizontal





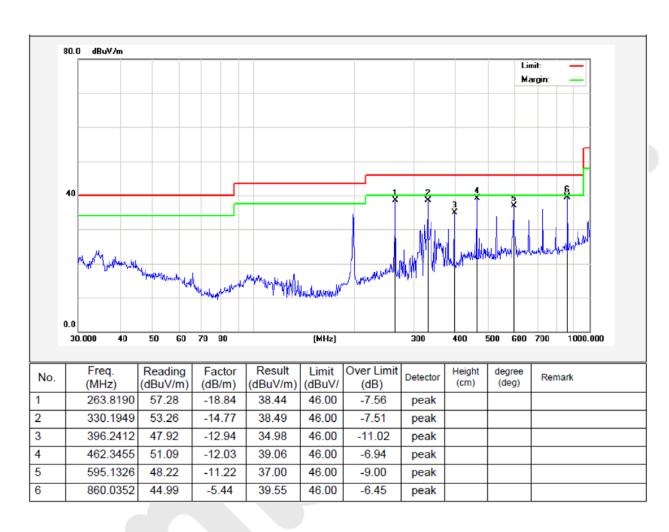
1 CC ID. 2AI 30-31 K-000

Test Results (30~1000MHz)

Job No.: 0217040065W Temp.(°C)/Hum.(%RH): 24.3 °C/55%RH

Standard: FCC PART 15C Power Source: DC 3.7V Battery inside

Test Mode: TX Mode Polarization: Vertical





Test Results (Above 1000MHz)

Test Mode:	ΓX Mode			Test	channel: Lowe	est		
				Peak Value				
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4804.00	38.80	34.04	6.58	34.09	45.33	74.00	-28.67	V
7206.00	32.82	37.11	7.73	34.50	43.16	74.00	-30.84	V
9608.00	32.35	39.31	9.23	34.79	46.10	74.00	-27.90	V
12010.00	*					74.00		V
14412.00	*					74.00		V
4804.00	43.40	34.04	6.58	34.09	49.93	74.00	-24.07	Н
7206.00	34.71	37.11	7.73	34.50	45.05	74.00	-28.95	Н
9608.00	31.92	39.31	9.23	34.79	45.67	74.00	-28.33	Н
12010.00	*					74.00		Н
14412.00	*					74.00		Н
			A	verage Valu	e			
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4804.00	27.33	34.04	6.58	34.09	33.86	54.00	-20.14	V
7206.00	21.34	37.11	7.73	34.50	31.68	54.00	-22.32	V
9608.00	20.33	39.31	9.23	34.79	34.08	54.00	-19.92	V
12010.00	*					54.00		V
14412.00	*					54.00		V
4804.00	31.73	34.04	6.58	34.09	38.26	54.00	-15.74	Н
7206.00	23.61	37.11	7.73	34.50	33.95	54.00	-20.05	Н
9608.00	20.18	39.31	9.23	34.79	33.93	54.00	-20.07	Н
12010.00	*					54.00		Н
14412.00	*					54.00		Н



Test Results (Above 1000MHz)

Test Mode:	ΓX Mode			Test	channel: Midd	le		
				Peak Value				
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4880.00	37.45	34.38	6.69	34.09	44.43	74.00	-29.57	V
7320.00	31.93	37.22	7.78	34.53	42.40	74.00	-31.60	V
9760.00	31.55	39.46	9.35	34.80	45.56	74.00	-28.44	V
12200.00	*					74.00		V
14640.00	*					74.00		V
4880.00	41.76	34.38	6.69	34.09	48.74	74.00	-25.26	Н
7320.00	33.69	37.22	7.78	34.53	44.16	74.00	-29.84	Н
9760.00	30.99	39.46	9.35	34.80	45.00	74.00	-29.00	Н
12200.00	*					74.00		Н
14640.00	*					74.00		Н
			A	verage Valu	e			
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol
4880.00	26.25	34.38	6.69	34.09	33.23	54.00	-20.77	V
7320.00	20.61	37.22	7.78	34.53	31.08	54.00	-22.92	V
9760.00	19.67	39.46	9.35	34.80	33.68	54.00	-20.32	V
12200.00	*					54.00		V
14640.00	*					54.00		V
4880.00	30.50	34.38	6.69	34.09	37.48	54.00	-16.52	Н
7320.00	22.79	37.22	7.78	34.53	33.26	54.00	-20.74	Н
9760.00	19.42	39.46	9.35	34.80	33.43	54.00	-20.57	Н
12200.00	*					54.00		Н
14640.00	*					54.00		Н



Test Results (Above 1000MHz)

Test Mode:	ΓX Mode			Test	channel: Highe	est		
	Peak Value							
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4960.00	36.70	34.72	6.79	34.09	44.12	74.00	-29.88	V
7440.00	31.43	37.34	7.82	34.57	42.02	74.00	-31.98	V
9920.00	31.11	39.62	9.46	34.81	45.38	74.00	-28.62	V
12400.00	*					74.00		V
14880.00	*					74.00		V
4960.00	40.87	34.72	6.79	34.09	48.29	74.00	-25.71	Н
7440.00	33.13	37.34	7.82	34.57	43.72	74.00	-30.28	Н
9920.00	30.48	39.62	9.46	34.81	44.75	74.00	-29.25	Н
12400.00	*					74.00		Н
14880.00	*					74.00		Н
			A	verage Valu	e			
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4960.00	25.70	34.72	6.79	34.09	33.12	54.00	-20.88	V
7440.00	20.23	37.34	7.82	34.57	30.82	54.00	-23.18	V
9920.00	19.34	39.62	9.46	34.81	33.61	54.00	-20.39	V
12400.00	*					54.00		V
14880.00	*					54.00		V
4960.00	29.87	34.72	6.79	34.09	37.29	54.00	-16.71	Н
7440.00	22.37	37.34	7.82	34.57	32.96	54.00	-21.04	Н
9920.00	19.03	39.62	9.46	34.81	33.30	54.00	-20.70	Н
12400.00	*					54.00		Н
14880.00	*					54.00		Н

Remark

- 1. Level =Receiver Read level + Antenna Factor + Cable Loss Preamplifier Factor
- 2. "*", means this data is the too weak instrument of signal is unable to test.



Radiated Band Edge:

Test Mode: 0	GFSK			Test	channel: Lowe	est		
	Peak Value							
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
2390.00	47.53	29.15	3.41	34.01	46.08	74.00	-27.92	Н
2400.00	64.98	29.16	3.43	34.01	63.56	74.00	-10.44	Н
2390.00	48.52	29.15	3.41	34.01	47.07	74.00	-26.93	V
2400.00	67.51	29.16	3.43	34.01	66.09	74.00	-7.91	V
			A	verage Value	e			
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
2390.00	37.03	29.15	3.41	34.01	35.58	54.00	-18.42	Н
2400.00	48.54	29.16	3.43	34.01	47.12	54.00	-6.88	Н
2390.00	37.30	29.15	3.41	34.01	35.85	54.00	-18.15	V
2400.00	45.63	29.16	3.43	34.01	44.21	54.00	-9.79	V

Test Mode: 0	GFSK			Test	channel: Highe	est		
	Peak Value							
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
2483.50	50.18	29.28	3.53	34.03	48.96	74.00	-25.04	Н
2500.00	48.47	29.30	3.56	34.03	47.30	74.00	-26.70	Н
2483.50	51.80	29.28	3.53	34.03	50.58	74.00	-23.42	V
2500.00	49.91	29.30	3.56	34.03	48.74	74.00	-25.26	V
			A	verage Valu	e			
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
2483.50	39.91	29.28	3.53	34.03	38.69	54.00	-15.31	Н
2500.00	37.25	29.30	3.56	34.03	36.08	54.00	-17.92	Н
2483.50	41.51	29.28	3.53	34.03	40.29	54.00	-13.71	V
2500.00	37.55	29.30	3.56	34.03	36.38	54.00	-17.62	V

Remark:

1. Level =Receiver Read level + Antenna Factor + Cable Loss - Preamplifier Factor

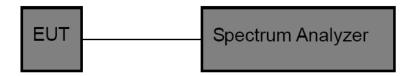


5. Maximum Peak Output Power Test

5.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.247 (b)(3)
Test Limit	30dBm

5.2. Test Setup



5.3. Test Procedure

This procedure shall be used when the measurement instrument has available a resolution bandwidth that is greater than the DTS bandwidth.

- 1. Set the RBW ≥DTS bandwidth.
- 2. Set the VBW≥3*RBW.
- 3. Set the span $\geq 3*RBW$.
- 4. Detector = peak.
- 5. Sweep time = auto couple.
- 6. Trace mode = \max hold.
- 7. Allow trace to fully stabilize.
- 8. Use peak marker function to determine the peak amplitude level.

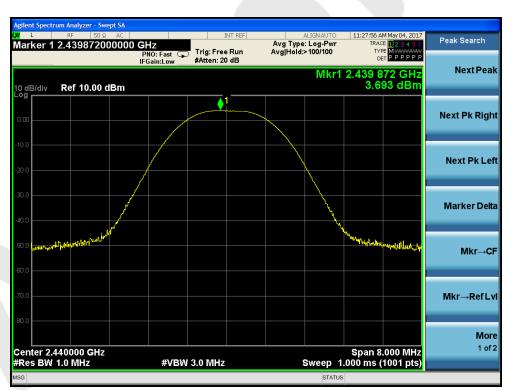
5.4. Test Data

Test Item	•	Max. peak output power	Test Mode	:	CH Low ~ CH High
Test Voltage	:	DC 3.7V By Battery	Temperature	:	24℃
Test Result	•	PASS	Humidity	:	55%RH

Channel Frequency (MHz)	Peak Power output (dBm)	Limit (dBm)	Results
2402	4.676	30	PASS
2440	3.693	30	PASS
2480	3.645	30	PASS



CH: Low



CH: Middle



CH: High

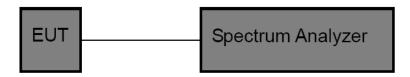


6. 6DB Occupy Bandwidth Test

6.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.247 (a)(2)
Test Limit	>500kHz

6.2. Test Setup



6.3. Test Procedure

- 1. Place the EUT on the table and set it in the transmitting mode.
- 2. Remove the antenna from the EUT and then connect a low loss RF cable from the antenna port to the spectrum analyzer.
- 3. Set the spectrum analyzer as:

RBW = 100kHz, VBW $\geqslant 3*RBW = 300kHz$,

Detector= Peak

Trace mode= Max hold.

Sweep- auto couple.

- 4. Mark the peak frequency and –6dB (upper and lower) frequency.
- 5. Repeat until all the rest channels are investigated.

6.4. Test Data

Test Item	:	6dB Bandwidth	Test Mode :	CH Low ~ CH High
Test Voltage	:	DC 3.7V By Battery	Temperature :	24℃
Test Result	:	PASS	Humidity :	55%RH

Channel	Frequency(MHz)	Bandwidth (kHz)	Limit (kHz)	Results
Low	2402	750.2		PASS
Middle	2440	797.6	>500	PASS
High	2480	798.1		PASS



CH: Low



CH: Middle



CH: High

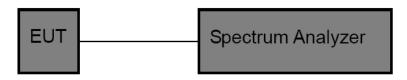


7. Power Spectral Density Test

7.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.247 (e)
Test Limit	8dBm

7.2. Test Setup



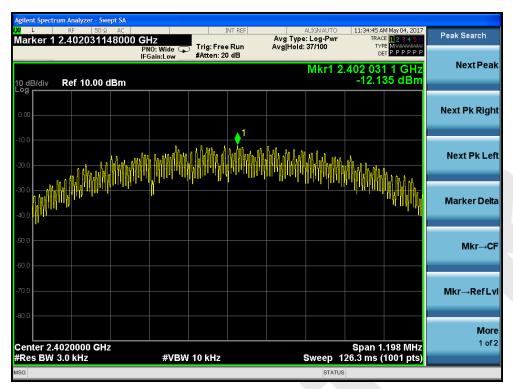
7.3. Test Procedure

- 1. Place the EUT on the table and set it in transmitting mode. Remove the antenna from the EUT and then connect a low loss RF cable from the antenna port to the spectrum analyzer.
- 2. Set the spectrum analyzer as RBW = 3kHz, VBW = 10kHz, Span = 1.5xDTS BW
- 3. Record the max. reading.
- 4. Repeat the above procedure until the measurements for all frequencies are completed.

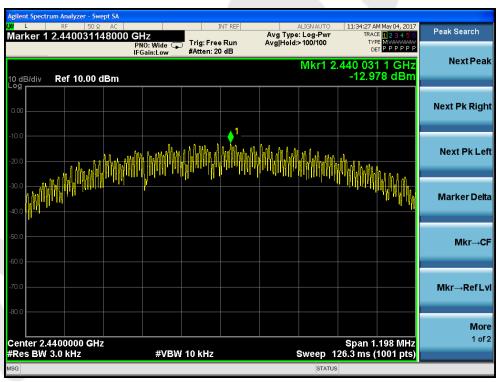
7.4. Test Data

Test Item : Power Spectral Density Test Mode : CH Low \sim CH High Test Voltage : DC 3.7V By Battery Temperature : 24° C Test Result : PASS Humidity : 55° RH

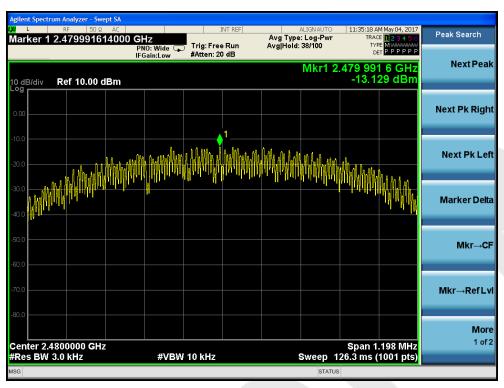
Channel	Frequency (MHz)	PPSD (dBm/3KHz)	Limit (dBm/3KHz)	Results
Low	2402	-12.135	8.00	PASS
Middle	2440	-12.978	8.00	PASS
High	2480	-13.129	8.00	PASS



CH: Low



CH: Middle



CH: High



8. 100kHz Bandwidth of Frequency Band Edge Requirement

8.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.247 (d)	
Test Limit	in any 100 kHz bandwidth outside the frequency bands in which the spread spectrum intentional radiator in operating, the radio frequency power that is produced by the intentional radiator shall be at least 20dB below that in the 100kHz bandwidth within the band that contains the highest level of the desired power, In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in15.209(a).	

8.2. Test Setup



8.3. Test Procedure

Using the following spectrum analyzer setting:

- 1. Set the RBW = 100KHz.
- 2. Set the VBW = 300KHz.
- 3. Sweep time = auto couple.
- 4. Detector function = peak.
- 5. Trace mode = max hold.
- 6. Allow trace to fully stabilize.

8.4. Test Data

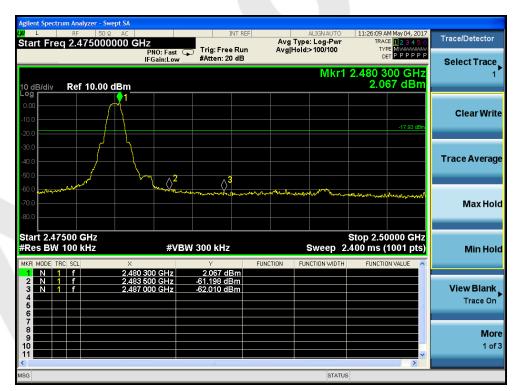
Test Item : Band edge : CH Low ~ CH High

Test Voltage : DC 3.7V By Battery Temperature : 24° C Test Result : PASS Humidity : 55° RH

Frequency Band (MHz)	Delta Peak toBand Emission (dBc)	Limit (dBc)	Results
2400	53.187	>20	PASS
2483.5	63.265	>20	PASS



CH: Low



CH: High



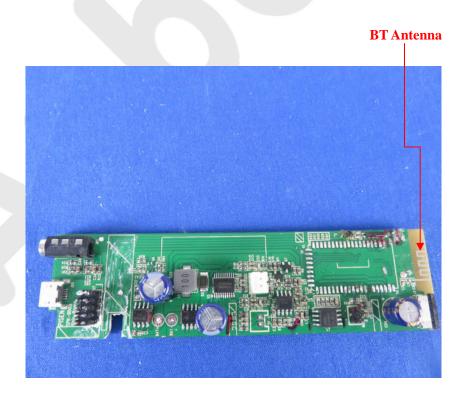
9. Antenna Requirement

9.1. Test Standard and Requirement

Test Standard	FCC Part15 Section 15.203 /247(c)
Requirement	1) 15.203 requirement: An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator, the manufacturer may design the unit so that a broken antenna can be replaced by the user, but the use of a standard antenna jack or electrical connector is prohibited. 2) 15.247(c) (1)(i) requirement: Systems operating in the 2400-2483.5 MHz band that is used exclusively for fixed. Point-to-point operations may employ transmitting antennas with directional gain greater than 6dBi provided the maximum conducted output power of the intentional radiator is reduced by 1 dB for every 3 dB that the directional gain of the antenna exceeds 6 dBi.

9.2. Antenna Connected Construction

The bluetooth antenna is a PCB antenna which permanently attached, and the best case gain of the antenna is 0.5dbi. It complies with the standard requirement.



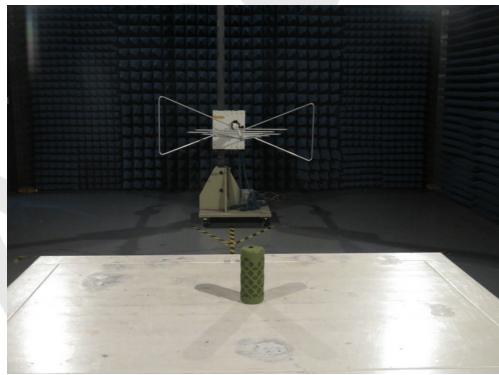


APPENDIX I -- TEST SETUP PHOTOGRAPH





Photo of Radiation Emission Test









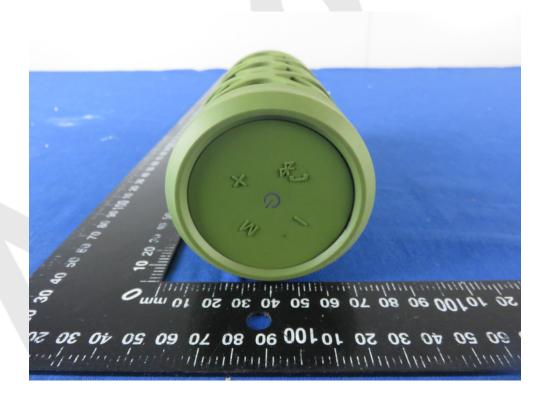
APPENDIX II -- EXTERNAL PHOTOGRAPH















APPENDIX III -- INTERNAL PHOTOGRAPH

